

INTERNATIONAL STANDARD

NORME INTERNATIONALE

**Directly heated negative temperature coefficient thermistors –
Part 1: Generic specification**

**Thermistances à coefficient de température négatif à chauffage direct –
Partie 1: Spécification générique**



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INTERNATIONAL
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CONTENTS

| | |
|----------------------------------------------------------------------------|----|
| FOREWORD..... | 7 |
| 1 Scope..... | 9 |
| 2 Normative references..... | 9 |
| 3 Terms and definitions | 10 |
| 4 General items | 20 |
| 4.1 Units and symbols..... | 20 |
| 4.2 Preferred values and appropriate category..... | 20 |
| 4.2.1 General | 20 |
| 4.2.2 Appropriate category..... | 20 |
| 4.3 Marking..... | 20 |
| 4.3.1 General | 20 |
| 4.3.2 Marking for small size types such as surface mount thermistors | 21 |
| 4.3.3 Coding..... | 21 |
| 4.4 Quality assessment procedures | 21 |
| 5 Test and measurement procedures | 21 |
| 5.1 General..... | 21 |
| 5.2 Standard atmospheric conditions for testing..... | 21 |
| 5.3 Drying and recovery | 22 |
| 5.3.1 Drying..... | 22 |
| 5.3.2 Recovery | 22 |
| 5.4 Mounting (for surface mount thermistors only)..... | 22 |
| 5.4.1 General | 22 |
| 5.4.2 Substrate and pad..... | 22 |
| 5.4.3 Mounting on board..... | 22 |
| 5.5 Visual examination and check of dimensions | 23 |
| 5.5.1 Visual examination..... | 23 |
| 5.5.2 Dimensions..... | 24 |
| 5.6 Zero-power resistance..... | 24 |
| 5.6.1 General | 24 |
| 5.6.2 Measurement procedures | 24 |
| 5.6.3 Requirements | 24 |
| 5.7 <i>B</i> -value or resistance ratio..... | 25 |
| 5.7.1 General | 25 |
| 5.7.2 Requirements | 25 |
| 5.8 Insulation resistance (for insulated types only)..... | 25 |
| 5.8.1 General | 25 |
| 5.8.2 Test methods..... | 25 |
| 5.8.3 Applied voltage | 27 |
| 5.8.4 Requirements | 28 |
| 5.9 Voltage proof (for insulated types only)..... | 28 |
| 5.9.1 General | 28 |
| 5.9.2 Test voltage..... | 28 |
| 5.9.3 Requirements | 28 |
| 5.10 Resistance/temperature characteristic | 28 |
| 5.10.1 General | 28 |
| 5.10.2 Test methods..... | 28 |
| 5.10.3 Requirements | 28 |

| | | |
|--------|--------------------------------------------------------------------------------|----|
| 5.11 | Dissipation factor (δ) | 28 |
| 5.11.1 | General | 28 |
| 5.11.2 | Initial measurements | 29 |
| 5.11.3 | Test methods | 29 |
| 5.11.4 | Requirements | 30 |
| 5.12 | Thermal time constant by ambient temperature change (τ_a) | 30 |
| 5.12.1 | General | 30 |
| 5.12.2 | Initial measurements | 30 |
| 5.12.3 | Preconditioning | 31 |
| 5.12.4 | Test methods | 31 |
| 5.12.5 | Final measurements and requirements | 31 |
| 5.12.6 | Requirements | 31 |
| 5.13 | Thermal time constant by cooling after self-heating (τ_c) | 31 |
| 5.13.1 | General | 31 |
| 5.13.2 | Initial measurements | 31 |
| 5.13.3 | Preconditioning | 31 |
| 5.13.4 | Test method | 32 |
| 5.13.5 | Final measurements and requirements | 32 |
| 5.14 | Robustness of terminations (not applicable to surface mount thermistors) | 32 |
| 5.14.1 | General | 32 |
| 5.14.2 | Initial measurements | 32 |
| 5.14.3 | Test methods | 33 |
| 5.14.4 | Test Ua ₁ – Tensile | 33 |
| 5.14.5 | Test Ub – Bending (half the number of terminations) | 33 |
| 5.14.6 | Test Uc – Torsion (remaining terminations) | 33 |
| 5.14.7 | Final measurements and requirements | 33 |
| 5.15 | Resistance to soldering heat | 33 |
| 5.15.1 | General | 33 |
| 5.15.2 | Preconditioning | 34 |
| 5.15.3 | Test procedure | 34 |
| 5.15.4 | Recovery | 34 |
| 5.15.5 | Final inspection, measurement and requirements | 34 |
| 5.16 | Solderability | 34 |
| 5.16.1 | General | 34 |
| 5.16.2 | Test procedure | 34 |
| 5.16.3 | Final inspection, measurements and requirements | 35 |
| 5.17 | Rapid change of temperature | 35 |
| 5.17.1 | General | 35 |
| 5.17.2 | Initial measurements | 35 |
| 5.17.3 | Test procedures | 35 |
| 5.17.4 | Final inspection, measurements and requirements | 35 |
| 5.18 | Vibration | 36 |
| 5.18.1 | General | 36 |
| 5.18.2 | Initial measurements | 36 |
| 5.18.3 | Test procedures | 36 |
| 5.18.4 | Final inspection, measurements and requirements | 36 |
| 5.19 | Shock | 36 |
| 5.19.1 | General | 36 |

| | | |
|--------|-------------------------------------------------------------------------------------------------------------------------------------------|----|
| 5.19.2 | Initial measurements | 36 |
| 5.19.3 | Mounting..... | 36 |
| 5.19.4 | Test procedures | 36 |
| 5.19.5 | Final inspection, measurements and requirements | 37 |
| 5.20 | Free fall | 37 |
| 5.20.1 | General | 37 |
| 5.20.2 | Initial measurements | 37 |
| 5.20.3 | Test procedures | 37 |
| 5.20.4 | Final inspection, measurements and requirements | 37 |
| 5.21 | Thermal shock | 37 |
| 5.21.1 | General | 37 |
| 5.21.2 | Initial measurements | 37 |
| 5.21.3 | Test procedures | 37 |
| 5.21.4 | Final inspection, measurements and requirements | 37 |
| 5.22 | Cold..... | 38 |
| 5.22.1 | General | 38 |
| 5.22.2 | Initial measurements | 38 |
| 5.22.3 | Test procedures | 38 |
| 5.22.4 | Final inspection, measurements and requirements | 38 |
| 5.23 | Dry heat..... | 38 |
| 5.23.1 | General | 38 |
| 5.23.2 | Initial measurements | 38 |
| 5.23.3 | Test procedures | 39 |
| 5.23.4 | Final inspection, measurements and requirements | 39 |
| 5.24 | Damp heat, steady state..... | 39 |
| 5.24.1 | General | 39 |
| 5.24.2 | Initial measurements | 39 |
| 5.24.3 | Test procedures | 39 |
| 5.24.4 | Recovery | 40 |
| 5.24.5 | Final inspection, measurements and requirements | 40 |
| 5.25 | Endurance | 40 |
| 5.25.1 | General | 40 |
| 5.25.2 | Endurance at room temperature with applied continuous maximum current (I_{max25}) (for inrush current-limiting thermistors only)..... | 40 |
| 5.25.3 | Endurance at room temperature with applied cyclic maximum current (I_{max25}) (for inrush current-limiting thermistors only) | 41 |
| 5.25.4 | Endurance at T_3 and P_{max} | 42 |
| 5.25.5 | Endurance at upper category temperature | 43 |
| 5.25.6 | Maximum permissible capacitance (for inrush current-limiting thermistors only) | 43 |
| 5.26 | Shear (adhesion) test (for surface mount thermistors only)..... | 45 |
| 5.26.1 | General | 45 |
| 5.26.2 | Test conditions | 45 |
| 5.26.3 | Requirements | 45 |
| 5.27 | Substrate bending test (for surface mount thermistors only) | 46 |
| 5.27.1 | General | 46 |
| 5.27.2 | Initial measurements | 46 |
| 5.27.3 | Test procedures | 46 |
| 5.27.4 | Final inspection and requirements | 46 |
| 5.28 | Component solvent resistance..... | 46 |

| | | |
|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------------------------------------------------------------------------------------------|----|
| 5.28.1 | General | 46 |
| 5.28.2 | Initial measurements | 46 |
| 5.28.3 | Test conditions | 46 |
| 5.28.4 | Requirements | 47 |
| 5.29 | Solvent resistance of marking | 47 |
| 5.29.1 | General | 47 |
| 5.29.2 | Test conditions | 47 |
| 5.29.3 | Requirements | 47 |
| 5.30 | Salt mist | 47 |
| 5.30.1 | General | 47 |
| 5.30.2 | Test conditions | 47 |
| 5.31 | Sealing | 47 |
| 5.32 | Composite temperature/humidity cycle | 47 |
| 5.32.1 | General | 47 |
| 5.32.2 | Initial measurements | 47 |
| 5.32.3 | Test conditions | 48 |
| 5.32.4 | Final inspection, measurements and requirements | 48 |
| Annex A (normative) Interpretation of sampling plans and procedures as described in IEC 60410:1973 for use within quality assessment systems | | 49 |
| A.1 | Clause and subclause numbers of IEC 60410:1973 | 49 |
| Annex B (normative) Rules for the preparation of detail specifications for directly heated thermistors for electronic equipment for use within quality assessment systems | | 50 |
| B.1 | Drafting | 50 |
| B.2 | Reference standard | 50 |
| B.3 | Circulation | 50 |
| Annex C (informative) Typical examples of mountings for measurements of directly heated thermistors | | 51 |
| C.1 | Mounting for surface mount thermistors | 51 |
| Annex D (informative) Reference to IEC 60539-1:2008 | | 53 |
| Annex Q (normative) Quality assessment procedures | | 54 |
| Q.1 | General | 54 |
| Q.2 | Primary stage of manufacture | 54 |
| Q.3 | Structurally similar components | 54 |
| Q.4 | Qualification approval procedures | 55 |
| Q.4.1 | General | 55 |
| Q.4.2 | Test procedure for qualification approval | 55 |
| Q.4.3 | Maintenance of qualification approval | 55 |
| Q.5 | Quality conformance inspection | 56 |
| Q.6 | Certified test records of released lots | 56 |
| Q.7 | Delayed delivery | 56 |
| Q.8 | Release for delivery under qualification approval before the completion of group B tests | 56 |
| Q.9 | Alternative test methods | 56 |
| Q.10 | Unchecked parameters | 56 |
| Bibliography | | 57 |
| Figure 1 – Typical resistance-temperature characteristic for NTC thermistors | | 13 |
| Figure 2 – Decreased power dissipation curve | | 15 |
| Figure 3 – Maximum current derating | | 17 |

| | |
|-----------------------------------------------------------------------------------------------------------|----|
| Figure 4 – Basic circuit for zero-power resistance measurement | 24 |
| Figure 5 – Example of Method 1 for testing the insulation resistance..... | 25 |
| Figure 6 – Example of Method 2 for testing the insulation resistance (1) | 26 |
| Figure 7 – Example of Method 2 for testing the insulation resistance (2) | 26 |
| Figure 8 – Example of Method 3 for testing the insulation resistance..... | 27 |
| Figure 9 – Example of Method 4 for testing the insulation resistance..... | 27 |
| Figure 10 – Example of test chamber | 29 |
| Figure 11 – Dissipation factor measuring circuit..... | 30 |
| Figure 12 – Thermal time constant measuring circuit | 32 |
| Figure 13 – Endurance at room temperature with $I_{\max 25}$ evaluating circuit..... | 41 |
| Figure 14 – Maximum permissible capacitance test circuit (Method 1)..... | 44 |
| Figure 15 – Maximum permissible capacitance test circuit (Method 2)..... | 45 |
| Figure C.1 – Mounting for measurements of surface mount thermistors..... | 52 |
| | |
| Table 1 – Lower and upper category temperatures and duration of the comp heat, steady state test | 20 |
| Table 2 – Tensile force | 33 |

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**DIRECTLY HEATED NEGATIVE TEMPERATURE
COEFFICIENT THERMISTORS –****Part 1: Generic specification**

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International Standard IEC 60539-1 has been prepared by IEC technical committee 40: Capacitors and resistors for electronic equipment.

This third edition cancels and replaces the second edition published in 2008. This edition constitutes a technical revision. Tables, figures and references have been revised.

The text of this standard is based on the following documents:

| FDIS | Report on voting |
|--------------|------------------|
| 40/2430/FDIS | 40/2457/RVD |

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 60539 series, published under the general title *Directly heated negative temperature coefficient thermistors*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC website under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

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DIRECTLY HEATED NEGATIVE TEMPERATURE COEFFICIENT THERMISTORS –

Part 1: Generic specification

1 Scope

This part of IEC 60539 is applicable to directly heated negative temperature coefficient thermistors, typically made from transition metal oxide materials with semiconducting properties.

It establishes standard terms, inspection procedures and methods of test for use in sectional and detail specifications of electronic components for quality assessment or any other purpose.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60062, *Marking codes for resistors and capacitors*

IEC 60068-1:2013, *Environmental testing – Part 1: General and guidance*

IEC 60068-2-1, *Environmental testing – Part 2-1: Tests – Tests A: Cold*

IEC 60068-2-2, *Environmental testing – Part 2-2: Tests – Tests B: Dry heat*

IEC 60068-2-6, *Environmental testing – Part 2-6: Tests – Test Fc: Vibration (sinusoidal)*

IEC 60068-2-11, *Basic environmental testing procedures – Part 2-11: Tests – Test Ka: Salt mist*

IEC 60068-2-14, *Environmental testing – Part 2-14: Tests – Test N: Change of temperature*

IEC 60068-2-17, *Basic environmental testing procedures – Part 2-17: Tests – Test Q: Sealing*

IEC 60068-2-20, *Environmental testing – Part 2-20: Tests – Test T: Test methods for solderability and resistance to soldering heat of devices with leads*

IEC 60068-2-21, *Environmental testing – Part 2-21: Tests – Test U: Robustness of terminations and integral mounting devices*

IEC 60068-2-27, *Environmental testing – Part 2-27: Tests – Test Ea and guidance: Shock*

IEC 60068-2-31, *Environmental testing – Part 2-31: Tests – Test Ec: Rough handling shocks, primarily for equipment-type specimens*

IEC 60068-2-38, *Environmental testing – Part 2-38: Tests – Test Z/AD: Composite temperature/humidity cyclic test*